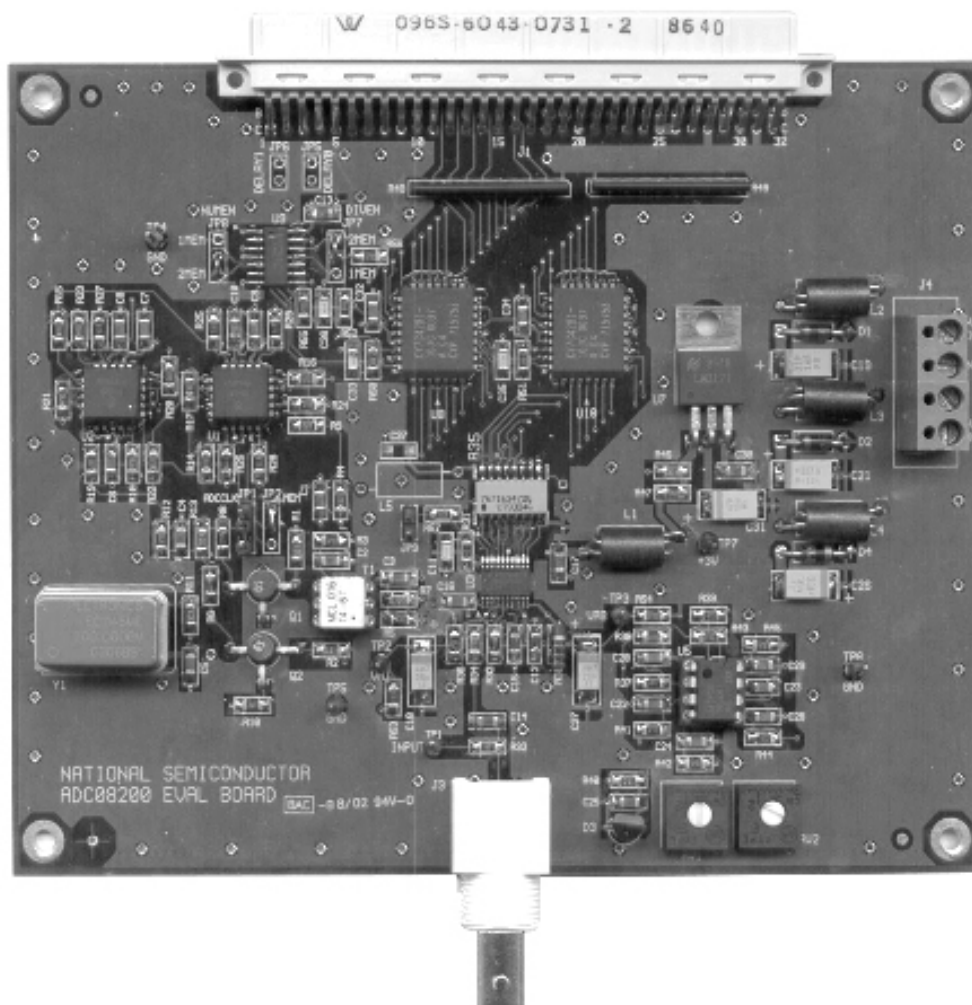


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# Evaluation Board User's Guide

**ADC08200 8-Bit, 10 MSPS to 230 Msps, Analog-to-Digital Converter  
with Internal Sample & Hold**



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## 1.0 Introduction

The ADC08200EVAL Design Kit (consisting of the ADC08200 Evaluation Board, National Semiconductor's WaveVision® software and this manual) is designed to ease evaluation and design-in of National's ADC08200 8-bit Analog-to-Digital Converter, which operates at sample rates up to 230 Msps.

The WaveVision software operates under Microsoft Windows®. The signal at the Analog Input is digitized and can be captured and displayed on the computer monitor as dynamic waveforms. The digitized output is also available at Euro connector J1.

The software can perform an FFT on the captured data upon command. This FFT display also shows dynamic performance in the form of SNR, SINAD, THD and SFDR.

Evaluation with this system is simplified by connecting the board to the WaveVision Data Capture Board (order number WAVEVSN BRD 3.0), which is connected to a personal computer through a serial communication port and running WaveVision software, operating under Microsoft Windows. Use program WAVEVSN2.EXE or WaveVision4, available at National Semiconductor's web site. This board will NOT function with WaveVision4 or WaveVision5 Data Capture Boards.

The signal at the Analog Input to the board is digitized and is available at pins B16 through B19 and C16 through C19 of J1. Pins A16 through A21 of J1 are ground pins.

Provision is made for adjustment of the Reference Voltages,  $V_{RT}$  and  $V_{RB}$  with potentiometers VR1 and VR2, respectively. These voltages are regulated with an LM4040-2.5 reference.

## 2.0 Board Assembly

The ADC08200 Evaluation Board comes pre-assembled but may be obtained as a bare board that must be assembled. Refer to the Bill of Materials for a description of components, to *Figure 1* for major component placement and to *Figure 2* for the Evaluation Board schematic.

## 3.0 Quick Start

Refer to *Figure 1* for locations of test points and major components.

1. Connect the evaluation board to the Data Capture Board (order number WAVEVSN BRD 3.0). See the Data Capture Board Manual for operation of that board.
2. Install a 200 MHz (or lower) oscillator into socket Y1. While the oscillator may be soldered to the board, using a socket will allow you to easily change clock frequencies.
3. Connect a clean power supply to the terminals of connector P1. Adjust power supply to voltages of +4.75V to +5.25V at pins 1 and 3 and -5.2 to -5.3V at pin 4 (ground is pin 2) before connecting it to the board. Turn on the power and confirm that there is 3 Volts at TP7 or at the pins of inductor L1.
4. Use RV1 to set the top reference voltage ( $V_{RFT}$ ) for the ADC to  $1.9V \pm 0.05V$  at TP2. Use RV2 to set the bottom reference voltage ( $V_{RFB}$ ) for the ADC to  $0.3V \pm 0.05V$  at TP3.
5. Connect the jumper at JP1 to pins 2 and 3 (those closest to Q1) to use oscillator Y1 frequency without dividing it by 2.
6. If they are not hard wired, connect the jumper at JP2 and JP8 to pins 2 and 3 (those closest to input BNC J3) and the jumper at JP7 to pins 1 and 2 (those farthest from input BNC J3) to use both FIFOs U8 and U10.
7. Connect a signal of 1.6V<sub>p-p</sub> amplitude from a 50-Ohm source to Analog Input BNC J3. The ADC input signal can be observed at TP1. Because of isolation resistor R32 and the scope probe capacitance, the input signal at TP1 will not have the same frequency response as will the ADC input signal.
8. The WaveVision3 Data Capture Board should be set up for 10 MHz operation with an 80MHz oscillator installed. See the Data Capture Board manual.
9. See the Data Capture Board Manual for data gathering instructions.

**NOTE:** The FFT will not indicate the correct frequencies because this information is derived from the clock frequency selected on the Data Capture Board. To show the correct frequency information on the FFT, double click on the FFT window to open the FFT Dialog Box, then click on "Frequency", enter the sample rate in MHz, then click on "OK". Alternatively, you may double click on the data capture window before performing the FFT and change the frequency at "Sampling Rate of This Data (MHz)" to 200 to indicate a 200 MHz sample rate.

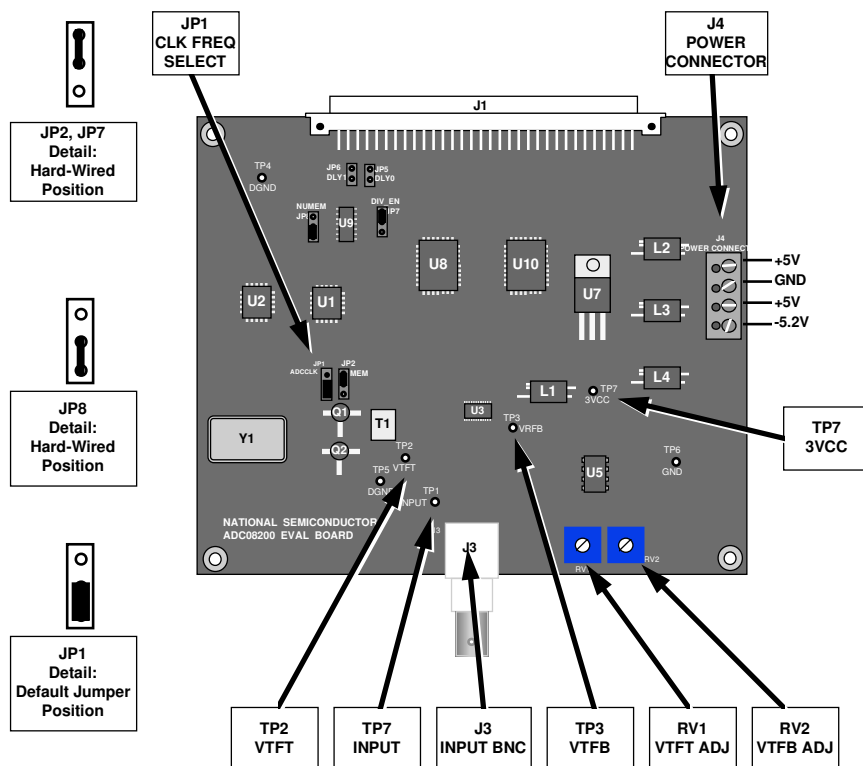


Figure 1. Component and Test Point Locations

## 4.0 Functional Description

The ADC08200 Evaluation Board schematic is shown in Figure 2.

### 4.1 Input (signal conditioning) circuitry

The input signal to be digitized should be applied to BNC connector J3. This 50 Ohm input is intended to accept a low-noise sine wave signal of 1.6V peak-to-peak amplitude. To accurately evaluate the ADC08200 dynamic performance, the input test signal should be passed through a high-quality bandpass filter (60dB minimum stop-band attenuation) as even the best signal sources do not provide a pure enough sine wave to properly evaluate an ADC.

The input to the ADC08200 is a.c. coupled through capacitor C14. Resistors R33A and R33B provide the needed input bias to the ADC08200. If d.c. coupling is desired, be sure that the input signal remains within the limits set by  $V_{RT}$  at TP2 and  $V_{RB}$  at TP3.

### 4.2 ADC reference circuitry

The provided reference circuitry will provide nominal reference voltage ranges of 1.3V to 2.5V for  $V_{RFT}$  and 0V to 1.3V for  $V_{RFB}$ . Providing for nominal input ranges of 0V to 2.5V peak-to-peak.

The reference voltages for the ADC08200 can be monitored at test points TP2 and TP3 and are set with RV1 and RV2. Signal offset can be provided by adjusting both of these potentiometers.

### 4.3 ADC clock circuit

The board is shipped ready to accept an ECL clock oscillator at a frequency of your choosing and is shipped without an oscillator in its socket. 200 MHz oscillators are not readily available, but a suitable 200 MHz oscillator is available from Pletronics, Inc. as their part number EC1145ME-200.0MPST.

Note that the divide by 2 function (JP1) does not function. A lower clock frequency requires the use of a lower frequency oscillator.

An ECL-level crystal oscillator may be installed at Y1, or the desired frequency may be applied to pin 8 of the Y1 socket. The signal level should be ECL levels.

**Caution:** Be sure that the oscillator used has the above suggested levels. We have found oscillators with levels outside of this range will not work properly in the circuit designed for this board.

R31 and C11 are used for high frequency termination of the clock line. An 80MHz clock oscillator should be used on the Data Capture Board with that board's clock divider set for 4. See the Data Capture Board manual for details on setting the clock divider.

Note that the reported sample rate is the rate at which the FIFO is read, so it is necessary to manually change this by double clicking on the data window after each data capture and changing the sample rate to that actually used.

## 4.4 Digital Data Output.

The digital output data from the ADC08200 is available at the 96-pin Euro connector J1. The series resistors of R35 isolate the ADC from the load circuit to reduce noise coupling into the ADC.

## 4.5 Power Supply Connections

Power to this board is supplied through power connector J4. The ADC08200 evaluation board requires +5V at pins 1 and 3 and -5.2V at pin 4. Pin 2 is ground.

When using the ADC08200 Evaluation Board with the Data Capture Board, the 5V logic power supply for the interface board is passed through the ADC08200 evaluation board from pin 3 of Power Connector J4. The supply voltages are protected by shunt diodes D1, D2 and D4. The +3 Volts needed for the ADC08200 is provided with voltage regulator U7, an LM317T.

## 4.6 Power Requirements

Voltage and current requirements for the ADC08200 Evaluation Board are:

- Pin 1 of P1: +5.0V  $\pm$ 5% at 3 mA
- Pin 3 of P1: +5.0V  $\pm$ 5% at 1.0 A.
- Pin 4 of P1: - 5.2V to -5.3V at 250 mA.

Pin 2 of J4 is ground. The +5V supply at pin 3 of the Power Connector P1 provides the power to the Data Capture Board, where most of the power through this pin is consumed.

## 5.0 Installing and Using the ADC08200 Evaluation Board

The evaluation board requires power supplies as described in Section 4.6. An appropriate signal source (such as the HP3325B, HP8662A or the Tektronix TSG130A) with 50 Ohm source impedance should be connected to the Analog Input BNC J3. The generator output should be filtered by a bandpass filter when evaluating sinusoidal signals to be sure there are no unwanted frequencies (harmonics and noise) presented to the ADC. A cable with a DB-9 connector must be connected between the Data Capture Board and the host computer. See the Data Capture Board manual for details.

## 5.1 Software Installation

The WaveVision software provided requires 300k bytes of hard drive space and will run under Windows.

1. Insert the disk into a 3.5" floppy drive.
2. Copy the program WAVEVSN2.EXE to the desired subdirectory on your computer's hard disk and RUN it.

Alternatively, you may download the software from national Semiconductor's ADC web site.

## 5.2 Setting up the ADC08200 Evaluation Board

This evaluation package was designed to be easy and simple to use, and to provide a quick and simple way to evaluate the ADC08200. The procedures given here will help you to properly set up the board.

### 5.2.1 Board Set-up

Refer to Figure 1 for locations of connectors, test points and jumpers on the board.

#### 5.2.1.1 Computer Mode Operation

1. Be sure a 200MHz clock oscillator (Y1) is in place on the ADC08200 evaluation board and an 80MHz oscillator is on the Data Capture board.
2. Set jumper JP1 to its default position, as shown in *Figure 1* so that the clock oscillator frequency is NOT divided by two for the ADC08200.
3. Connect The ADC08200 evaluation board to Data Capture Board, WAVEVSN BRD 3.0.
4. Connect a cable with DB-9 connector between the Data Capture Board connector P1 and a serial port on your computer.
5. Connect power to the board per requirements of section 4.6.
6. Connect an appropriate signal source to BNC connector J3 of the ADC08200 evaluation board. Remember to use an appropriate filter, as discussed in sections 4.1 and 5.0.
7. Capture data by clicking on the sine wave icon of the WaveVision software, or press CTRL-X on the keyboard.

#### 5.2.1.2 Manual Mode Operation

1. Perform steps 1, 2 and 5 of section 5.2.1.1, above.
2. Monitor the ADC08200 output at 96-pin connector J1 pins B16 through B19 and C16 through C19 (see appendix for pin assignments).
4. Clock the data out with a TTL clock of any speed up to 200 MHz at pin B15 of 96-pin connector J1.

### 5.2.2 Quick Check of Analog Functions

Refer to Figure 1 for locations of connectors, test points and jumpers on the board. If at any time the expected response is not obtained, see section 5.2.6 on Troubleshooting.

1. Perform steps 1 through 6 (steps 3 and 4 are optional here) of Section 5.2.1.1.
2. Check for the presence of correct d.c. voltages at power connector J4, as called for in section 4.6.
3. Check TP7 or either terminal of L1 for the presence of a voltage between 2.7V and 3.3V.
4. JP1 - Short the two pins closest to Q1 (pins 2 & 3) to NOT divide the on-board clock oscillator by 2.
5. Adjust RV1 for a voltage of 1.87V to 1.93V at TP2.



- Adjust RV2 for a voltage of 0.27V to 0.33V at TP4.
- Adjust the signal source at Analog Input J3 for a signal amplitude of approximately 1.6V<sub>p-p</sub> and check for the presence of that signal at TP1.

This completes the testing of the analog portion of the evaluation board.

### 5.2.3 Quick Check of Software and Computer Interface Operation

- Perform steps 1 through 5 of Section 5.2.1.1, above.
- Supply a 1.6V<sub>p-p</sub> sine wave of 1 MHz to 50MHz at Analog Input BNC J3.
- Be sure there is an interconnecting cable between the board and your computer serial port.
- RUN program WAVEVS2.EXE.
- After turning on the power, be sure to wait for yellow LED D4 on the Data Capture Board to go out (about 5 seconds) before trying to acquire data or the board will "freeze" and you will have to cycle the power.
- Acquire data by clicking on the ACQUIRE icon or by pressing ALT, P, A or CTRL-X. Data transfer can take a few seconds.
- When transfer is complete, the data window should show many sine waves. The display may show a nearly solid area of red, which is O.K.
- Double click on the data window and change the "Sampling Rate of this data (MHz)" to 200. This must be done each time another data capture is done or the frequency information in the FFT will not be correct.
- With the mouse, you may click and drag to select a portion of the displayed waveform for better examination.
- Click on the FFT icon or type ALT, P, F or CTRL-F to calculate the FFT of the data and display a frequency domain plot.

The FFT data will provide a measurement of SINAD, SNR, THD and SFDR, easing the performance verification of the ADC08200. Note that the readings may not accurately reflect the ADC08200's actual performance unless an input filter is used, as explained in sections 4.1 and 5.0, and unless the sampling is coherent, as explained below.

### 5.2.4 Getting Consistent Readings

Artifacts can result when we perform an FFT on a digitized waveform, producing inconsistent results when testing repeatedly. The presence of these artifacts means that the ADC under test may perform better than the measurements would indicate.

We can eliminate the need for windowing and get more consistent results if we observe the proper ratios between the input and sampling frequencies. This greatly increases the spectral resolution of the

FFT, allowing us to more accurately evaluate the spectral response of the A/D converter. When we do this, however, we must be sure that the input signal has high spectral purity and stability and that the sampling clock signal is extremely stable with minimal jitter.

Coherent sampling of a periodic waveform occurs when an integer number of cycles exists in the sample window. The relationship between the number of cycles sampled (CY), the number of samples taken (SS), the signal input frequency ( $f_{in}$ ) and the sample rate ( $f_s$ ), for coherent sampling, is

$$\frac{CY}{SS} = \frac{f_{in}}{f_s}$$

CY, the number of cycles in the data record, must be an integer number and SS, the number of samples in the data record, must be a factor of 2 integer. For optimum results, CY should also be a prime number.

Further,  $f_{in}$  (signal input frequency) and  $f_s$  (sampling rate) should be locked to each other. If they come from the same generator, whatever frequency instability (jitter) is present in the two signals will cancel each other.

Windowing (an FFT Option under WaveVision) should be turned off for coherent sampling.

### 5.2.5 Jumper Information

Table 1 indicates the function and use of the jumpers on the ADC08200 evaluation board. JP2, JP7 and JP8 are hard-wired for 2 memory chips.

JUMPER	FUNCTION	PINS 1 & 2 SHORTED	PINS 2 & 3 SHORTED
JP1	Clock Select	Divide Clock by 2	Do not Divide Clock
JP2	No of Mem Chips	1 Mem Chip	2 Mem Chips
JP7	No of Mem Chips	2 Mem Chips	1 Mem Chip
JP8	No of Mem Chips	1 Mem Chip	2 Mem Chips

Table 1. Jumper settings.

### 5.2.6 Troubleshooting

"Comm Check Failed", "Error Transmitting", "Parallel Port Time Out Error" and/or "Failed to communicate with the board on LPT1" errors mean communication was unsuccessful. Try the following:

- Be sure to wait for yellow LED D4 on the Data Capture Board to go out after turning on power before trying to capture data.
- Be sure that the Data Capture Board is connected to a serial printer port and has power.
- Be sure the proper port is selected (type ALT-O).
- Ascertain that an 80MHz clock oscillator is properly inserted into the socket at Y1 of the Data Capture Board and that the DIP switches on the

Data Capture Board are properly set (see the Data Capture Board manual). Check to see that LEDs D1 and D3 of the Data Capture Board are on. See the Data Capture Board manual for their functions.

- Be sure cable connections are solid.
- Be sure that the board to computer cable is not a Null Modem type. If it is, swap the jumpers J8 and J10 on the Data Capture Board.

If there is no output from the ADC08200, perform the following:

- Be sure that the proper voltages and polarities are present at Power Connector P1 (especially the -5.2V).
- Be sure +3 Volts is present on terminals of L1, or at TP7.
- Be sure that R57 is mounted correctly. See <http://www.national.com/appinfo/adc/files/ADC08200-R57.pdf>.
- Be sure there is an input signal at J3 and TP1 and that the signal source and input filter are of compatible frequencies.
- Be sure positions JP2, JP7 and JP8 are wired.

If the displayed waveform appears to be garbage, or if the FFT plot shows nothing but noise with no apparent signal:

- Be sure clock Y1 is of the proper frequency (200MHz) and type (ECL with output swing between -0.6V and -1.3V).
- Be sure positions JP2, JP7 and JP8 are wired.

Problem Opening Comm Port" or "Error Setting Comm State" errors mean that the comm port selected is not the one to which the eval board is connected.

Inconsistent or poor performance could be caused by reading the FIFO too fast. Reading fo the FIFO should be done at 10 MHz. See Data Capture Board manual for information on setting the sampling frequency of that board.

## **6.0 Evaluation Board Specifications**

Board Size:	4.8" x 6.0" (12.2cm x 15.2 cm)
Power Requirements:	+ 5V $\pm$ 5% @ 3.0 mA
(see Section 4.6)	+ 5V $\pm$ 5% @ 1 Amp
	- 5.2V to -5.3V @ 250 mA
Clock Frequency Range:	10 MHz to 230 MHz
Analog Input	
Nominal Voltage:	1.6V <sub>P-P</sub>
Frequency Range	50 KHz to 400 MHz
Impedance:	50 Ohms

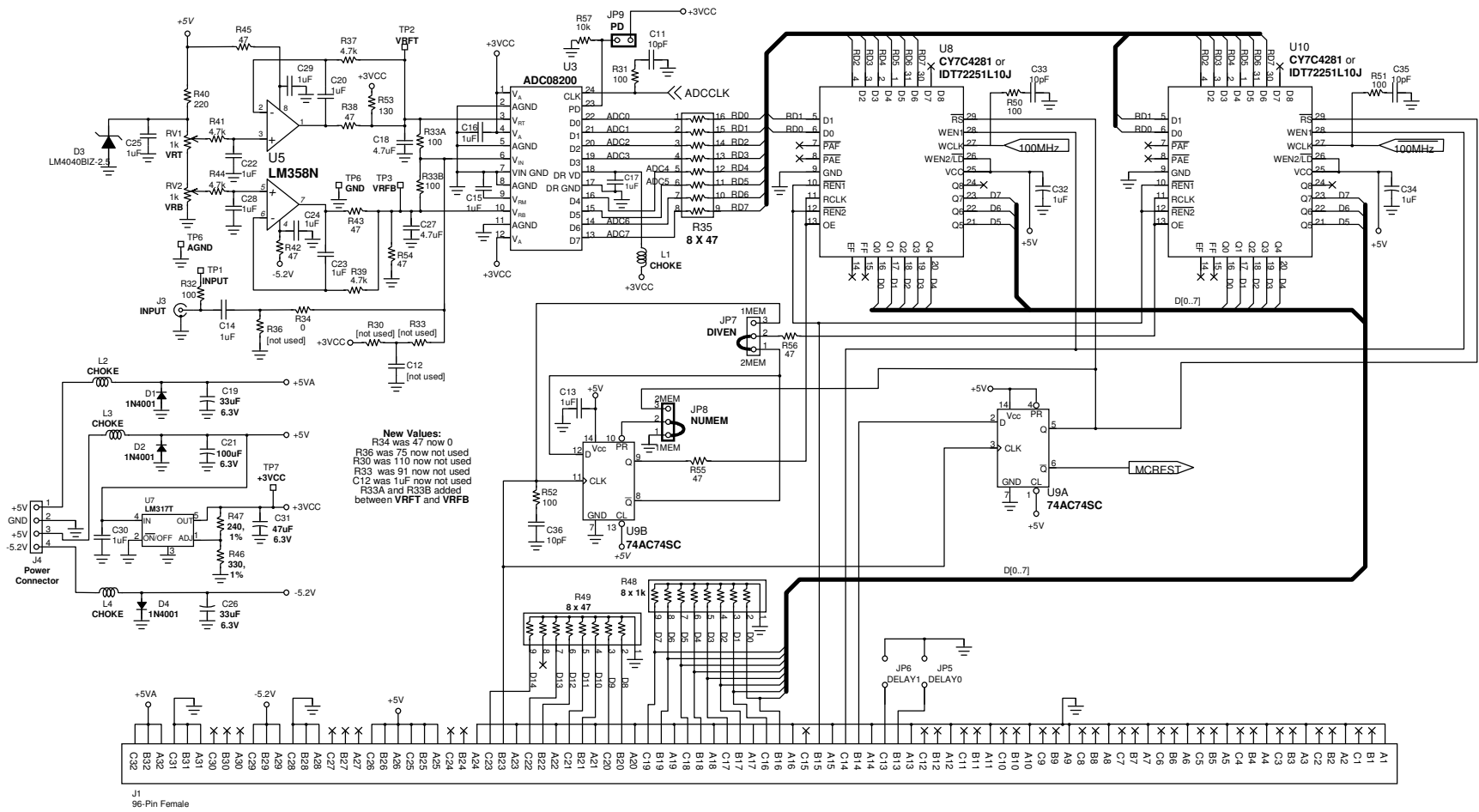


Figure 2a. ADC 08200 Evaluation Board Schematic

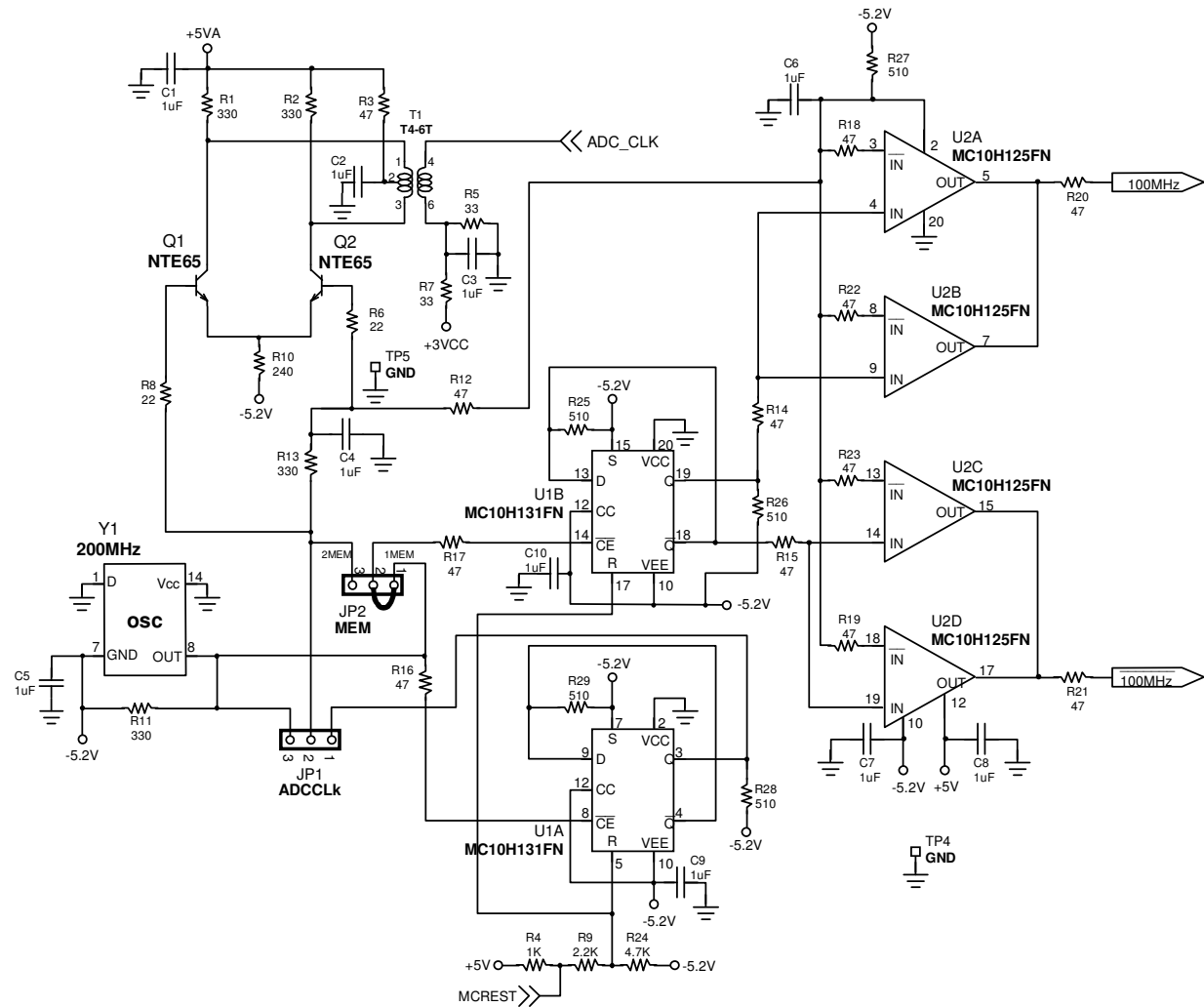


Figure 2b. ADC 08200 Evaluation Board Clock source

## 8.0 Evaluation Board Bill of Materials

Item	Qty	Reference	Part	Source
1	24	C1, C2, C3, C4, C5, C6, C7, C8, C9, C10, C13, C14, C15, C16, C17, C20, C22, C23, C24, C25, C28, C29, C30, C32, C34	1uF	Type 1206
2	4	C11, C33, C35, C36	10pF	Type 1206
3	2	C18, C27	4.7uF	Type 7343 (D Size)
4	2	C19, C26	33uF, 6V	Type 7343 (D Size)
5	1	C21	100uF, 6V	Type 7343 (D Size)
6	1	C31	47uF, 6V	Type 7343 (D Size)
7	-	C12, C37	<b>not populated</b>	n/a
8	3	D1, D2, D4	1N4001	Various
9	1	D3	LM4040EIZ-2.5	National Semiconductor
10	1	J1	96-Pin Female	DigiKey # H7096-ND
11	1	JP1	3-Pin Post Header	DigiKey # A19351-ND
12	1	Shorting Jumper	Shorting Jumper	DigiKey # S9001-ND
13	-	JP2, JP7, JP8, JP9	<b>3-Pin Post Header - Bd Rev A.</b>	DigiKey # A19351-ND
14	-	JP10	<b>Factory Set - Board Rev B</b>	n/a
15	1	J3	<b>Factory Set - board rev A</b>	n/a
16	2	J4	<b>Doesn't exist - Board Rev B</b>	
17	1	JP5, JP6	BNC Connector	DigiKey # ARF1177-ND
18	4	L1, L2, L3, L4	Terminal Block	DigiKey # ED1609-ND
19	-	L5	<b>not populated</b>	n/a
20	2	Q1, Q2	Choke	DigiKey # M2204-ND
21	1	R34	<b>not populated</b>	n/a
22	2	R6, R8	NTE65	NTE Electronics
23	2	R5, R7	0 (short)	
24	19	R3, R12, R14, R15, R16, R17, R18, R19, R20, R21, R22, R23, R38, R42, R43, R45, R54, R55, R56	22	Type 1206
25	5	R31, R32, R50, R51, R52	33	Type 1206
26	2	R33A, R33B	47	Type 1206
27	1	R53	100	Type 1206
28	1	R40	100	¼ W, Leaded
29	2	R10, R47	130	Type 1206
30	5	R1, R2, R11, R13, R46	220	Type 1206
31	5	R25, R26, R27, R28, R29	240	Type 1206
32	1	R4	330	Type 1206
33	1	R9	510	Type 1206
34	5	R24, R37, R39, R41, R44	1k	Type 1206
35	1	R57	2.2k	Type 1206
36	3	R30, R33, R36	4.7k	Type 1206
37	1	R35	10k	Type 1206
38	1	R49	<b>not populated</b>	n/a
39	1	R48	Resistor Pack - 8 x 47	DigiKey # 767-163-R47-ND
40	2	RV1, RV2	Resistor Pack (SIP) - 8 x 47	DigiKey # 750-101-R47-ND
41	1	TP1, TP2, TP3, TP4, TP5, TP6, TP7	Resistor Pack (SIP) - 8 x 1k	DigiKey # 750-101-R1k-ND
42	1	T1	1k Pot	DigiKey # 3386P-102-ND
43	1	U1	Breakable Header	DigiKey # S1012-36-ND
44	1	U2	Transformer	MiniCircuits T4-6T
45	1	U3	MC10H131FN	ON Semiconductor
46	1	U5	MC10H125FN	ON Semiconductor
47	1	U7	ADC08200CIMT	National Semiconductor
48	2	U8, U10	LM358N	National Semiconductor
49	1	U9	LM317T	National Semiconductor
50	1	Y1	IDT72251L10J or CY7C4251V-10JC or CY7C4281V-10JC 74AC74SC / 74ACT74SC 200 MHz Oscillator	IDT Cypress Semiconductor Cypress Semiconductor Fairchild Semiconductor
51	1	6-Pin DIP Socket	<b>NOT POPULATED</b>	
52	1	Full-Size 4-Pin Oscillator Socket	EC1145ME-200.0MPST or M1700-200.00M M1900-200.00M	Pletronics Valey-Fisher Valey-Fisher
53	1	8-Pin DIP Socket	Transformer Socket	DigiKey # AE8906-ND
54	1	PC Board	Oscillator Socket for Y1 For U5 ADC08200, Rev B	DigiKey # A462-ND DigiKey # A400-ND Bay Area Circuits

# APPENDIX

## Summary Tables of Test Points and Connectors

### Test Points on the ADC08200 Evaluation Board

TP 1	Signal Input test point
TP 2	ADC Top Reference Voltage, $V_{RT}$
TP 3	ADC Bottom Reference Voltage, $V_{RB}$
TP 4	Ground
TP 5	Ground
TP 6	Ground
TP 7	+3V test point (Grounded on initial board version)

### P1 Connector - Power Supply Connections

J4-1	+5V	Positive Power Supply
J4-2	GND	Power Supply Ground
J4-3	+5V	Logic and Data Capture Board Supply
J4-4	-5.2	Negative Power Supply

### JP1 Jumper - ADC Clock

Connect 1-2	Divide Clock Oscillator (Y1) frequency by 2
Connect 2-3	Use Clock Oscillator (Y1) frequency without dividing it (Default)

### JP2 Jumper - Memory

Connect 1-2	Use one FIFO chip
Connect 2-3	Use both FIFO chips (Default hard-wired position)

### JP3 thru JP6 - Not Used

### JP7 Jumper - Divide Enable

Connect 1-2	Use both FIFO chips - divide FIFO read signal frequency by 2 (Default hard-wired position)
Connect 2-3	Use one FIFO chip - do not divide FIFO read signal

### JP8 Jumper - Number of Memory Chips

Connect 1-2	One Memory Chip
Connect 2-3	Two Memory Chips (Default hard-wired position)

### JP9 Jumper - Power Down

No Jumper	ADC080200 in active state
Jumper Present	ADC080200 in Power Down mode

**J1 Connector - ADC Data Outputs - Connection to WaveVision Data Capture Board**

Signal	J1 pin number
ADC output D0	B16
ADC output D1	C16
ADC output D2	B17
ADC output D3	C17
ADC output D4	B18
ADC output D5	C18
ADC output D6	B19
ADC output D7	C19
ADC output D8	not used
ADC output D9	not used
ADC output D10	not used
ADC output D11	not used
GND	A1 thru A24, A28, B28, C28, A31, B31, C31
Memory Read Clock	B15
Reserved, Signal	B22, C22, C23
Reserved, Power	A25, A26, B25, B26, C25, C26 (+5V Logic Power Supply to Data Capture Board )
Reserved, Power (–5.2V)	A29, B29, C29
Reserved, Power (+5V)	A32, B32, C32

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1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

<b>National Semiconductor Corporation Americas</b> Tel: 1-800-272-9959 Fax: 1-800-737-7018 Email: support@nsc.com	<b>National Semiconductor Europe</b> Fax: +49 (0) 1 80-530 85 86 Email: europe.support@nsc.com Deutsch Tel: +49 (0) 699508 6208 English Tel: +49 (0) 870 24 0 2171 Français Tel: +49 (0) 1 41 91 87 90 Email: europe.support@nsc.com	<b>National Semiconductor Asia Pacific Customer Response Group</b> Tel: 65-254-4466 Fax: 65-250-4466 Email: ap.support@nsc.com	<b>National Semiconductor Japan Ltd.</b> Tel: 81-3-5639-7560 Fax: 81-3-5639-7507 Email: nsj.crc@jksmt.nsc.com
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